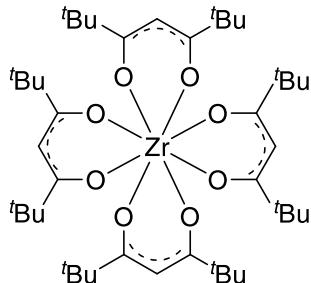


Catalog # 40-5000 Tetrakis(2,2,6,6-tetramethyl-3,5-heptanedionato)zirconium(IV), 99% [Zr(TMHD)4]
 Syn: Zr(DPM)4, Zr(THD)4



Thermal Behavior:

- Sublimation: 192°C/AP [1]; 200°C/AP [2-4]
- Decomposition: >370°C [1]
- Melting point (controversial): 318°C [1], 334°C [5] 341°C [6]
- Vapor pressure: 0.1 Torr/180°C [7], calculations and data are available in [2-3, 6]
- TGA diagram and data is available in [1-6]

Technical Notes:

- ALD/CVD precursor for Zr thin film deposition

Target Deposit	Deposition Technique	Delivery Temperature	Pressure	Co-reactants	Deposition Temperature	Ref.
ZrO ₂	ALD	170°C	1.5-2.25 Torr	O ₃	250-500°C	8
PbZrO ₃	ALD	130°C	2.25 Torr	Ph ₄ Pb, O ₃	275-300°C	9
Pb(Zr,Ti)O _x	ALD	200°C ^{Solv}	1 Torr	H ₂ O, Pb(thd) ₂ , Ti(thd) ₂ iPr ₂	240°C	10
Fe: ZrO ₂	ALD	170°C	-	O ₃	350°C	11

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